## Applicant(s)/Patent Under Application/Control No. Reexamination SHIBANUMA ET AL. 10/084,468 Notice of References Cited Examiner Art Unit Page 1 of 1 2165 Neveen Abel-Jalil **U.S. PATENT DOCUMENTS**

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	В	US-6,647,125	11-2003	Matsumoto et al.	382/100
	C	US-			
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	Е	US-			
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	1	US-			
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	К	US-			
	L	US-			
	М	US-			

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## **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.